Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,283	CHAPMAN, THOMAS R.	
Examiner	Art Unit	
Devin Hanan	3745	

	SEARCHED				
Class	Subclass	Date	Examiner		
415	206				
416	175,183				
	185, 187				
	186R				
264	328.1	4/20/2005	DH		
updated	above	10/5/2005	DH		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	L				

SEARCH (INCLUDING SEAR		")
	DATE	EXMR
consulted Chris Verdier on class 416 and 415	4/20/2005	DH
consulted Jill Heitbrink on class 264/328.1	4/13/2005	DH